TOSHIBA BIPOLAR DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

TD62783AFNG,TD62784AFNG

8CH HIGH-VOLTAGE HIGH SOURCE-CURRENT DRIVER

The TD62783AFNG, TD62784AFNG are comprised of eight source current Transistor Array.

These drivers are specifically designed for fluorescent display applications.

Applications include relay, hammer and lamp and display (LED) drivers.

This devices are a product for the Pb free(Sn-Ag).

FEATURES

Package Type : SSOP18 pin (0.65 mm pitch)
 High Ouptut Voltage : VCE (SUS) = 50 V (MIN)

• Output Current (Single Output) : IOUT = -500 mA (MAX)

Output Clamp Diodes

Single Supply Voltage

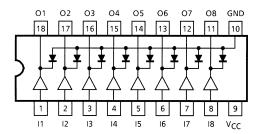
• Input Compatible with Various Types of Logic

ALTERNATION OF THE PARTY OF THE	
SSOP18-P-225-0.65	

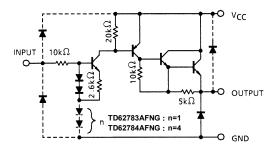
Weight: 0.09 g (Typ.)

TYPE	DESIGNATION
TD62783AFNG	TTL, 5 V CMOS
TD62784AFNG	6~15 V PMOS, CMOS

PIN CONNECTION (TOP VIEW)



SCHEMATICS (EACH DRIVER)



Note: The input and output parasitic diodes cannot be used as clamp diodes.



MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT	
Supply Voltage	V _{CC}	50	V	
Output Current	lout	-500	mA / ch	
Input Voltage	V _{IN} (Note 1)	15	V	
input voitage	V _{IN} (Note 2)	30	V	
Clamp Diode Reverse Voltage	V_{R}	50	V	
Clamp Diode Forward Current	IF	500	mA	
Power Dissipation	P _D (Note 3)	0.96	W	
Operating Temperature	T _{opr}	-40~85	°C	
Storage Temperature	T _{stg}	-55~150	°C	

Note 1: TD62783AFNG Note 2: TD62784AFNG

Note 3: On Glass Epoxy PCB (50 × 50 × 1.6 mm Cu 40%)

RECOMMENDED OPERATING CONDITIONS (Ta = -40~85°C)

CHARACTERISTIC		SYMBOL	CONDITION		MIN	TYP.	MAX	UNIT		
Supply Voltage		V _{CC}			_	_	50	V		
Output Current (Note 3)				DC 1 Circuit		_	_	-350		
		(Note 3)	I _{OUT}	T _{pw} = 25 ms, T _j = 120°C Ta = 85°C, 8 Circuits	Duty = 10 %	_	_	-180	mA / ch	
					Duty = 50 %	_	_	-38		
Input Voltage		(Note 1)	V _{IN}			_	_	12	V	
		(Note 2)				_	_	24	V	
Input Voltage	Output ON	(Note 1)	V _{IN} (ON)			2.0	5.0	15	V	
		(Note 2)				4.5	12.0	30		
	Output OFF	(Note 1)	V			0	_	0.8	V	
		Output OFF	(Note 2)	V _{IN(OFF)}			0	_	2.0	
Clamp Diode Reverse Voltage		V _R			_	_	50	V		
Clamp Diode Forward Current		I _F			_	_	400	mA		
Power Dissipation (Note 3)		P _D			_	_	0.4	W		

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Note 1: TD62783AFNG Note 2: TD62784AFNG

Note 3: On Glass Epoxy PCB (50 × 50 × 1.6 mm Cu 40%)



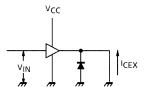
ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC		SYMBOL	TEST CIR- CUIT	TEST CONDITION	MIN	TYP.	MAX	UNIT	
Output Leakage Current		I _{CEX}	1	$V_{CC} = V_{CC} \text{ MAX}, V_{IN} = 0.4 \text{ V}$ Ta = 25°C	_	_	100	μA	
Output Saturation Voltage		VCE (sat)	2	$V_{IN} = V_{IN (ON)},$ $I_{OUT} = -350 \text{ mA}$	_	_	2.0	V	
				V _{IN} = V _{IN} (ON), I _{OUT} = -225 mA	_	_	1.9		
				V _{IN} = V _{IN} (ON), I _{OUT} = -100 mA	_	_	1.8		
	TD62783AFNG	- I _{IN (ON)}	3	V _{IN} = 2.4 V	_	36	52	μΑ	
Input Current				V _{IN} = 3.85 V	_	180	260		
	TD62784AFNG			V _{IN} = 5 V	_	92	130		
				V _{IN} = 12 V	_	790	1130		
	TD62783AFNG	V _{IN (ON)}	\/		V _{CE} = 2.0 V	_	_	2.0	
	TD62784AFNG		4	I _{OUT} = −350 mA	_	_	4.5	V	
Input Voltage	TD62783AFNG	V _{IN (OFF)}		Ι _{ΟUΤ} = -500 μΑ	8.0	_	_	V	
	TD62784AFNG		VIN (OFF)		1001 = 300 μΑ	2.0	_	_	
Supply Current		ICC (ON)	3	V _{IN} = V _{IN} (ON), V _{CC} = -50 V	_	_	2.5	mA / ch	
Clamp Diode Reverse Current		I _R	5	V _R = 50 V	_	_	50	μΑ	
Clamp Diode Forward Voltage		V _F	6	I _F = 350 mA	_	_	2.0	V	
Turn-On Delay		t _{ON}	7	$V_{CC} = V_{CC}MAX$, $R_L = 125 \Omega$ $C_L = 15 pF$	_	0.15	_	- µs	
Turn-Off Delay		t _{OFF}] ′		_	3.0	_		

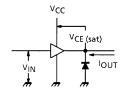
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TEST CIRCIT

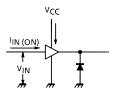
1. ICEX



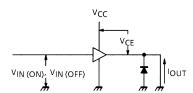
2. VCE (sat)



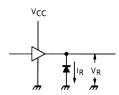
3. I_{IN} (ON), I_{CC}



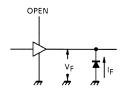
4. V_{IN (ON)}, V_{IN (OFF)}



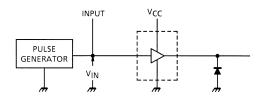
5. I_R

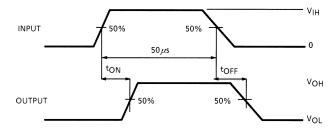


6. V_I



7. ton, toff





Note 1: Pulse Width 50 µs, Duty Cycle 10%

Ouptut Impedance 50 Ω , $t_f \le 5$ ns, $t_f \le 10$ ns

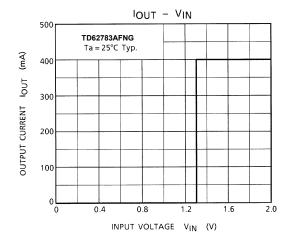
Note 2: CL includes probe and jig capacitance.

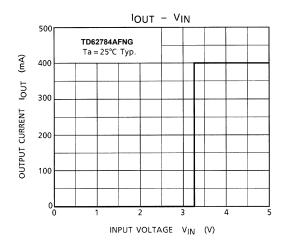
PRECAUTIONS for USING

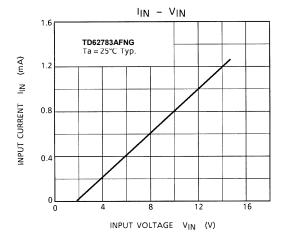
This IC does not integrate protection circuits such as overcurrent and overvoltage protectors.

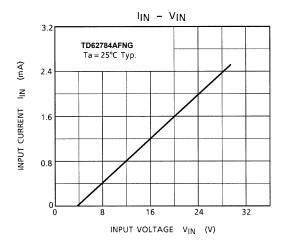
Thus, if excess current or voltage is applied to the IC, the IC may be damaged. Please design the IC so that excess current or voltage will not be applied to the IC.

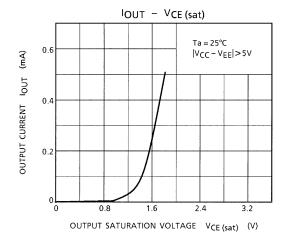
Utmost care is necessary in the design of the output line, VCC and GND line since IC may be destroyed due to short-circuit between outputs, air contamination fault, or fault by improper grounding.

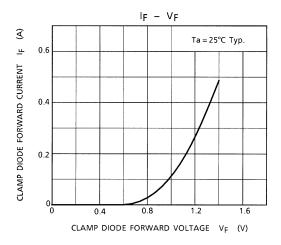


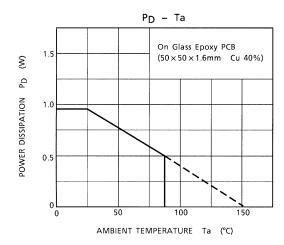






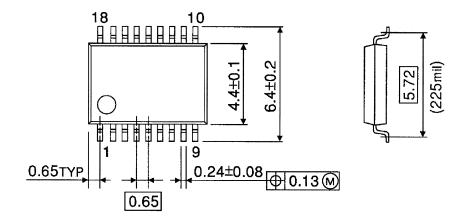


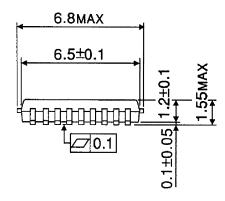


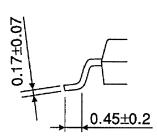


PACKAGE DIMENSIONS

SSOP18-P-225-0.65 Unit: mm







Weight: 0.09 g (Typ.)

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About solderability, following conditions were confirmed

- Solderability
 - (1) Use of Sn-63Pb solder Bath
 - solder bath temperature = 230°C
 - · dipping time = 5 seconds
 - · the number of times = once
 - · use of R-type flux
 - (2) Use of Sn-3.0Ag-0.5Cu solder Bath
 - · solder bath temperature = 245°C
 - · dipping time = 5 seconds
 - · the number of times = once
 - · use of R-type flux

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